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SNOSAS8A - APRIL 2011 - REVISED APRIL 2013

DS96F172MQML/DS96F174MQML EIA-485/EIA-422 Quad Differential Drivers

Check for Samples: DS96F172MQML, DS96F174MQML

FEATURES

- Meets EIA-485 and EIA-422 Standards
- **Monotonic Differential Output Switching**
- **TRI-STATE Outputs**
- **Designed for Multipoint bus Transmission**
- Common Mode Output Voltage Range: -7.0V to +12V
- Operates from Single +5.0V Supply
- **Reduced Power Consumption**
- **Thermal Shutdown Protection**
- DS96F172 and DS96F174 are Lead and Function Compatible with the SN75172/174 or the AM26LS31/MC3487

DESCRIPTION

The DS96F172 and the DS96F174 are high speed quad differential line drivers designed to meet EIA-485 Standards. The DS96F172 and the DS96F174 offer improved performance due to the use of L-FAST bipolar technology. The use of LFAST technology allows the DS96F172 and DS96F174 to operate at higher speeds while minimizing power consumption.

The DS96F172 and the DS96F174 have TRI-STATE outputs and are optimized for balanced multipoint data bus transmission at rates up to 15 Mbps. The drivers have wide positive and negative common mode range for multipoint applications in noisy environments. Positive and negative current-limiting is provided which protects the drivers from line fault conditions over a +12V to -7.0V common mode range. A thermal shutdown feature is also provided. The DS96F172 features an active high and active low Enable, common to all four drivers. The DS96F174 features separate active high Enables for each driver pair.

Connection Diagrams

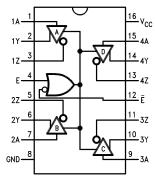


Figure 1. 16-Lead CDIP Package-Top View DS96F172 (See Package Number NFE0016A)

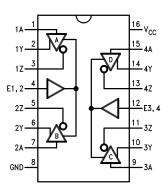
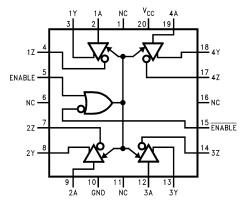


Figure 2. 16-Lead CDIP Package-Top View DS96F174 (See Package Number NFE0016A)

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NC = No connection

Figure 3. 20-Lead LCCC Package-Top View DS96F172 (see Package Number NAJ0020A)

17 1A NC VCC 4A 3 2 1 20 19 18 4Y E1, 2 5 NC 6 27 8 9 10 11 12 13 2A GND NC 3A 3Y

Figure 4. 20-Lead LCCC Package-Top View DS96F174 (see Package Number NAJ0020A)

Logic Diagrams

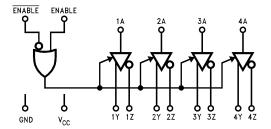


Figure 5. DS96F172

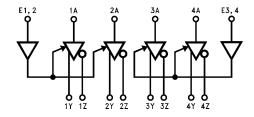


Figure 6. DS96F174



Function Tables (Each Driver)

Table 1. DS96F172⁽¹⁾

Input	Ena	ıble	Outputs			
Α	E		Y	Z		
Н	Н	Х	Н	L		
L	Н	Х	L	Н		
Н	X	L	Н	L		
L	X	L	L	Н		
X	L	Н	Z	Z		

⁽¹⁾ H = High Level

Table 2. DS96F174⁽¹⁾

Input	Enable	Out	puts
Α	E	Y	Z
Н	Н	Н	L
L	Н	L	Н
X	L	Z	Z

⁽¹⁾ H = High Level

Z = High Impedance (Off)



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings(1)

Storage Temperature Range (T _{Stg})	-65°C ≤ T _A ≤ +175°C
Lead Temperature (Soldering, 60 sec.)	300°C
Maximum Package Power Dissipation at 25°C ⁽²⁾	
LCCC package	2,000 mW
CDIP package	1,800 mW
Ceramic Flatpack package	1,000 mW
Supply Voltage	7.0V
Enable Input Voltage	5.5V

⁽¹⁾ Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not verify specific performance limits. For verified specifications and test conditions, see the Electrical Characteristics. The verified specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Recommended Operating Conditions

	Min	Max	Units
Supply Voltage (V _{CC})	4.50	5.50	V
Common Mode Output Voltage (V _{OC})	-7.0	+12.0	V
Output Current High (I _{OH})		-60	mA
Output Current Low (I _{OL})		60	mA
Operating Temperature (T _A)	-55	+125	°C

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L = Low Level

X = Don't Care

Z = High Impedance (Off)

L = Low Level

X = Don't Care

⁽²⁾ Above T_A = 25°C, derate LCCC package 13.3, CDIP package 12.5, Ceramic flatpack package 7.1 mW/°C



Quality Conformance Inspection

Table 3. Mil-Std-883, Method 5005 - Group A

Subgroup	Description	Temp (°C)
1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55
12	Settling time at	+25
13	Settling time at	+125
14	Settling time at	-55

DS96F172/DS96F174 Electrical Characteristics AC/DC Parameters⁽¹⁾

The following conditions apply, unless otherwise specified.

DC: $V_{CC} = 5.5V$ AC: $V_{CC} = 5.0V$

	Parameter	Test Conditions	Notes	Min	Max	Units	Sub- groups	
V	Logical Ollabort Valtage				0.8	V	1	
V_{IL}	Logical 0 Input Voltage				0.7	V	2, 3	
V_{IH}	Logical 1 Input Voltage			2.0		V	1, 2, 3	
V _{IC}	Input Clamp Voltage	I = -18mA		-1.5		V	1, 2, 3	
V _{OD1}	Differential Output Voltage	I _O = 0mA			6.0	V	1, 2, 3	
V	Differential Output Voltage	$V_{CC} = 4.5V, R_{L} = 54\Omega$		1.5		V	1, 2	
V_{OD2}	Differential Output Voltage	Figure 7	See ⁽²⁾	1.2		V	groups 1 2, 3 1, 2, 3 1, 2, 3 1, 2, 3	
V _{OD2}	Differential Output Voltage	$V_{CC} = 4.5V$, $R_L = 100\Omega$ Figure 7		2.0		V	1, 2, 3	
A) /	0, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1,	V 45V B 540	See ⁽³⁾	-200	200	mV	1, 2	
ΔV_{OD1}	Change In Magnitude of V _{OD2}	$V_{CC} = 4.5V$, $R_L = 54\Omega$	See ⁽²⁾⁽³⁾	-400	400	mV	3	
A) /	Change In Magnitude of V	V 45V B 4000	See ⁽³⁾	-200	200	mV	1, 2	
ΔV_{OD2}	Change In Magnitude of V _{OD2}	$V_{CC} = 4.5V, R_L = 100\Omega$	See ⁽²⁾⁽³⁾	-400	400	mV	3	
V _{OC}	Common Mode Output Voltage	$R_L = 54\Omega$ Figure 7			3.0	V	1, 2, 3	
V _{OC}	Common Mode Output Voltage	$R_L = 100\Omega$ Figure 7			3.0	V	1, 2, 3	
ΔV _{OC}	Change in Magnitude of V _{OC}	V_{CC} = 4.5V, R_L = 54 Ω Figure 7	See ⁽³⁾	-200	200	mV	1, 2, 3	
ΔV _{OC}	Change in Magnitude of V _{OC}	V_{CC} = 4.5V, R_L = 100 Ω Figure 7	See ⁽⁴⁾	-200	200	mV	1, 2, 3	
Io	Output Current With Power Off	$V_{CC} = 0V, V_{O} = -7V \text{ to } 12V$		-50	50	μA	1, 2, 3	

⁽¹⁾ All currents into the device pins are positive; all currents out of the device pins are negative. All voltages are reference to ground unless otherwise specified.

^{(2) -55°}C limit exceeds EIA standard RS-485 specification

⁽³⁾ $\Delta |V_{OD}|$ is the change in magnitude of V_{OD} , that occurs when the input is changed between high and low levels.

⁽⁴⁾ $\Delta |V_{OC}|$ is the change in magnitude of the V_{OC} that occurs when the input is changed between high and low levels.



DS96F172/DS96F174 Electrical Characteristics AC/DC Parameters⁽¹⁾ (continued)

The following conditions apply, unless otherwise specified.

DC: $V_{CC} = 5.5V$ AC: $V_{CC} = 5.0V$

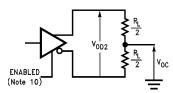
Parameter		Test Conditions	Notes	Min	Max	Units	Sub- groups		
l _{OZ}	High Impedance State Output Current	$V_O = -7V$ to 12V		-50	50	μΑ	1, 2, 3		
I _{IH}	Logical 1 Input Current	V _I = 2.4V			20	μΑ	1, 2, 3		
I _{IL}	Logical 0 Input Current	$V_I = 0.4V$		-50		μΑ	1, 2, 3		
I _{CC}	Supply Current	Outputs Enabled			50	mA	1, 2, 3		
I _{CCX}	Supply Current	Outputs Disabled			30	mA	1, 2, 3		
I _{OS1}	Short Circuit Output Current	V _O = -7V	See ⁽⁵⁾	-250		mA	1, 2, 3		
I _{OS2}	Short Circuit Output Current	V _O = 0V	See ⁽⁵⁾	-150		mA	1, 2, 3		
I _{OS3}	Short Circuit Output Current	$V_O = V_{CC}$	See ⁽⁵⁾		150	mA	1, 2, 3		
I _{OS4}	Short Circuit Output Current	V _O = 12V	See ⁽⁵⁾		250	mA	1, 2, 3		
	Barana Maria Balanda da Ulilarad	$R_L = 27\Omega$, $C_L = 15pF$			25	ns	groups IA 1, 2, 3 IA 1, 2, 3		
t _{PLH}	Propagation Delay Lo to Hi level	Figure 10			16	mA 1, 2, 3 ns 10, 11 ns 9			
	Barra and an Baland Bit to Love Love L	$R_L = 27\Omega, C_L = 15pF$			25	ns			
t _{PHL}	Propagation Delay Hi to Low Level	Figure 10			16	ns	9		
CKEW	Outside Outside Balantina	$R_L = 60\Omega$			10	ns 10, 1			
SKEW	Output to Output Delay Time				4	ns	9		
	Output Disable Time From Low Level	$R_L = 110\Omega, C_L = 50pF$			40				
t_{LZ}		Figure 12			25	ns	9		
	Output Disable Time From High Level	$R_L = 110\Omega, C_L = 50pF$			80	ns	10, 11		
t_{HZ}		Figure 11			30	ns	9		
	Output Enable Time to Low Level	$R_L = 110\Omega, C_L = 50pF$			100	ns	10, 11		
t_{ZL}		Figure 12			40				
	Output Enable Time to High Level	$R_L = 110\Omega, C_L = 50pF$			40	ns	10, 11		
t_{ZH}		Figure 10			32	ns	9		
	B.,,	$R_1 = 60\Omega, C_1 = 15pF$			30	ns	10, 11		
t_{DD}	Differential Output Delay Time	Figure 9			22	ns	9		
	Differential Output Transition Time	$R_1 = 60\Omega, C_1 = 15pF$			40	ns	10, 11		
t_{TD}		Figure 9			22	ns	9		

⁽⁵⁾ $0.2\mu F$ cap is connected between the output and Gnd to reduce oscillation.

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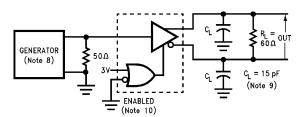


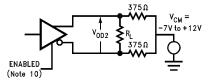
PARAMETER MEASUREMENT INFORMATION



Note 10: DS96F172 with active high and active low Enables is shown. DS96F174 has active high Enable only.

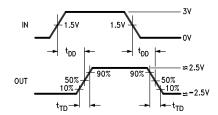
Figure 7. Differential and Common Mode Output Voltage





Note 10: DS96F172 with active high and active low Enables is shown. DS96F174 has active high Enable only.

Figure 8. Differential Output Voltage with Varying Common Mode Voltage

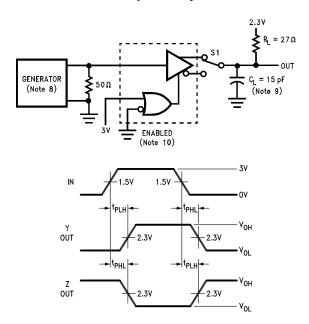


Note 8:The input pulse is supplied by a generator having the following characteristics: f = 1.0 MHz, duty cycle = 50%, $t_f \le 5.0$ ns, $t_f \le 5.0$ ns, t

Note 9:C_L includes probe and jig capacitance.

Note 10: DS96F172 with active high and active low Enables is shown. DS96F174 has active high Enable only.

Figure 9. Differential Output Delay and Transition Times



Note 8:The input pulse is supplied by a generator having the following characteristics: f = 1.0 MHz, duty cycle = 50%, $t_f \le 5.0$ ns, $t_f \le 5.0$ ns, t

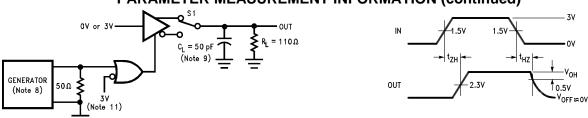
Note 9:C_L includes probe and jig capacitance.

Note 10: DS96F172 with active high and active low Enables is shown. DS96F174 has active high Enable only.

Figure 10. Propagation Delay Times



PARAMETER MEASUREMENT INFORMATION (continued)

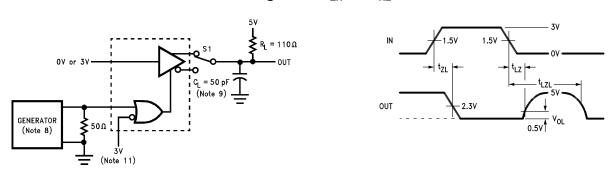


Note 8:The input pulse is supplied by a generator having the following characteristics: f = 1.0 MHz, duty cycle = 50%, $t_f \le 5.0$ ns, $t_f \le 5.0$ ns, t

Note 9:C_L includes probe and jig capacitance.

Note 11:To test the active low Enable \overline{E} of DS96F172 ground \overline{E} and apply an inverted waveform to \overline{E} . DS96F174 has active high Enable only.

Figure 11. t_{zH} and t_{HZ}



Note 8:The input pulse is supplied by a generator having the following characteristics: f = 1.0 MHz, duty cycle = 50%, $t_f \le 5.0$ ns, $t_f \le 5.0$ ns, t

Note 9:C_L includes probe and jig capacitance.

Note 11:To test the active low Enable \overline{E} of DS96F172 ground \overline{E} and apply an inverted waveform to \overline{E} . DS96F174 has active high Enable only.

Figure 12. t_{ZL}, t_{LZ}, t_{LZL}

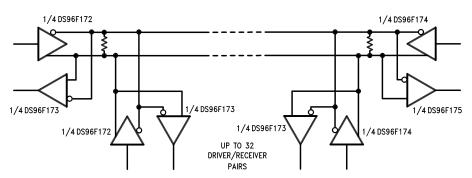
NOTE

For more information see Application Bulletin, Contact Product Marketing.

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TYPICAL APPLICATION



The line length should be terminated at both ends in its characteristic impedance. Stub lengths off the main line should be kept as short as possible.





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REVISION HISTORY

Released	Revision	Section	Changes
8–Apr-11	А		2 MDS data sheets converted into one Corp. data sheet format. MNDS96F172M-X Rev 1A0 & MNDS96F174M-X Rev 1B0 will be archived.

Cł	hanges from Original (April 2013) to Revision A	Pag	јe
•	Changed layout of National Data Sheet to TI format		8





18-Apr-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
5962-9076501M2A	ACTIVE	LCCC	NAJ	20	50	TBD	Call TI	Call TI	-55 to 125	DS96F172ME /883 Q 5962-90765 01M2A ACO 01M2A >T	Samples
5962-9076501MEA	ACTIVE	CDIP	NFE	16	25	TBD	Call TI	Call TI	-55 to 125	DS96F172MJ/883 5962-9076501MEA Q	Samples
5962-9076502M2A	ACTIVE	LCCC	NAJ	20	50	TBD	Call TI	Call TI	-55 to 125	DS96F174ME /883 Q 5962-90765 02M2A ACO 02M2A >T	Samples
5962-9076502MEA	ACTIVE	CDIP	NFE	16	25	TBD	Call TI	Call TI	-55 to 125	DS96F174MJ/883 5962-9076502MEA Q	Samples
5962-9076502VEA	ACTIVE	CDIP	NFE	16	25	TBD	Call TI	Call TI	-55 to 125	DS96F174MJ-QMLV 5962-9076502VEA Q	Samples
DS96F172ME/883	ACTIVE	LCCC	NAJ	20	50	TBD	Call TI	Call TI	-55 to 125	DS96F172ME /883 Q 5962-90765 01M2A ACO 01M2A >T	Samples
DS96F172MJ/883	ACTIVE	CDIP	NFE	16	25	TBD	Call TI	Call TI	-55 to 125	DS96F172MJ/883 5962-9076501MEA Q	Samples
DS96F174ME/883	ACTIVE	LCCC	NAJ	20	50	TBD	Call TI	Call TI	-55 to 125	DS96F174ME /883 Q 5962-90765 02M2A ACO 02M2A >T	Samples
DS96F174MJ-QMLV	ACTIVE	CDIP	NFE	16	25	TBD	Call TI	Call TI	-55 to 125	DS96F174MJ-QMLV 5962-9076502VEA Q	Samples
DS96F174MJ/883	ACTIVE	CDIP	NFE	16	25	TBD	Call TI	Call TI	-55 to 125	DS96F174MJ/883 5962-9076502MEA Q	Samples

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.





18-Apr-2013

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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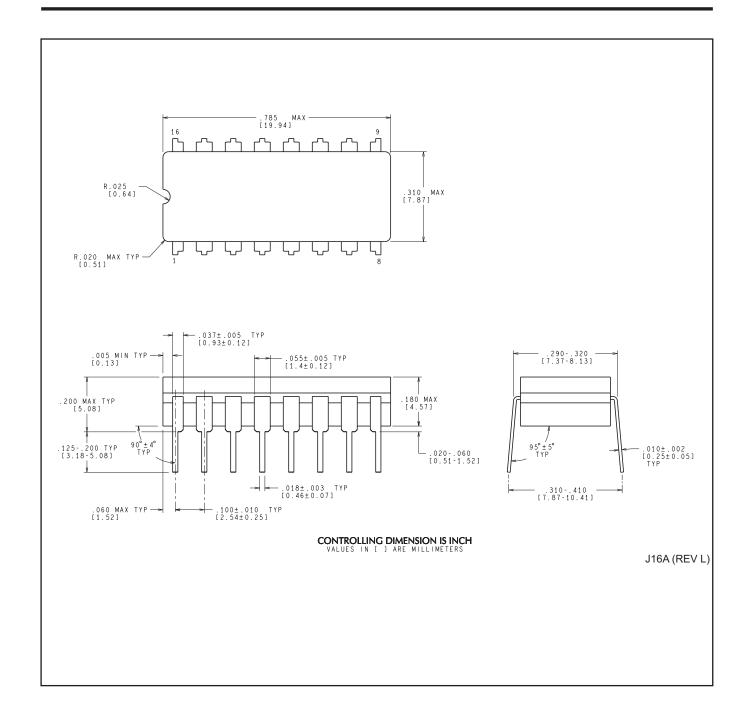
OTHER QUALIFIED VERSIONS OF DS96F174MQML, DS96F174MQML-SP:

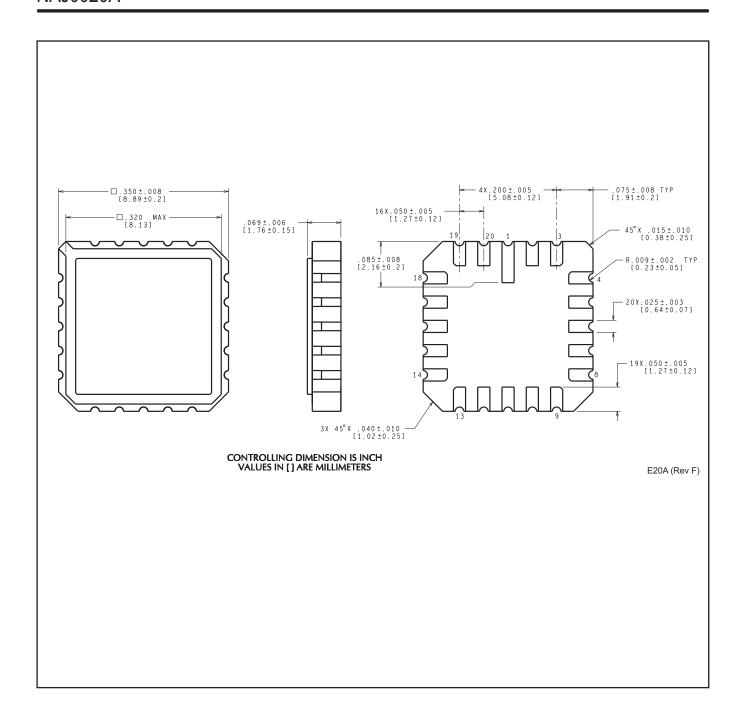
Military: DS96F174MQML

Space: DS96F174MQML-SP

NOTE: Qualified Version Definitions:

- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application





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